

# n-channel JFETs designed for . . .

**S**  
Siliconix

TO-92 SOT-23

- Analog Switches
- Choppers
- Commutators

## Performance Curves NVA See Section 4

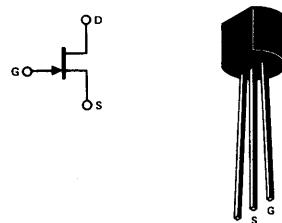
### BENEFITS

- Very Low Insertion Loss  
 $r_{DS(on)} < 3 \Omega$  (J105)
- No Offset or Error Voltages Generated by Closed Switch  
Purely Resistive  
High Isolation Resistance from Driver

TO-92  
See Section 6

### ABSOLUTE MAXIMUM RATINGS (25°C)

Gate-Drain or Gate-Source Voltage .....	25 V
Gate Current .....	50 mA
Total Device Dissipation at 25°C Ambient (Derate 3.27 mW/°C) .....	360 mW
Operating Temperature Range .....	-55 to 135°C
Storage Temperature Range .....	-55 to 150°C
Lead Temperature Range (1/16" from case for 10 seconds) .....	300°C



Bottom View

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### ELECTRICAL CHARACTERISTICS (25°C unless otherwise noted)

Characteristic		J105			J106			J107			Unit	Test Conditions				
		Min	Typ	Max	Min	Typ	Max	Min	Typ	Max						
1 S	I <sub>GSS</sub>	Gate Reverse Current (Note 1)			-3			-3			-3	nA	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = -15 V			
2 T	V <sub>GS(off)</sub>	Gate-Source Cutoff Voltage			-4.5	-10	-2	-6	-0.5	-4.5	V	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 1 μA				
3 A	BV <sub>GSS</sub>	Gate-Source Breakdown Voltage			-25	-25			-25				V <sub>DS</sub> = 0 V, I <sub>G</sub> = -1 μA			
4 T	I <sub>DSS</sub>	Drain Saturation Current (Note 2)			500	200			100			mA	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V			
5 C	I <sub>D(off)</sub>	Drain Cutoff Current (Note 1)				3		3			3	nA	V <sub>DS</sub> = 5 V, V <sub>GS</sub> = -10 V			
6	r <sub>D(on)</sub>	Drain Source ON Resistance				3		6			8	Ω	V <sub>DS</sub> ≤ 0.1 V, V <sub>GS</sub> = 0 V			
7	C <sub>Dg(off)</sub>	Drain Gate OFF Capacitance				35		35			35	pF	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = -10 V	f = 1 MHz		
8	C <sub>Sg(off)</sub>	Source Gate OFF Capacitance				35		35			35					
9 D	C <sub>Dg(on)</sub> + C <sub>Sg(on)</sub>		Drain Gate plus Source Gate ON Capacitance				160		160		160		V <sub>DS</sub> = V <sub>GS</sub> = 0 V			
10 M	t <sub>d(on)</sub>	15					15		15			Switching Time Test Conditions				
11 I	t <sub>r</sub>	20					20		20		ns	J105	J106	J107		
12 C	t <sub>d(off)</sub>	15					15		15			V <sub>DD</sub>	1.5 V	1.5 V	1.5 V	
13 t <sub>f</sub>	Fall Time	20					20		20			V <sub>GS(off)</sub>	-12 V	-7 V	-5 V	
													R <sub>L</sub>	50 Ω	50 Ω	50 Ω

#### NOTES:

- Approximately doubles for every 10°C increase in T<sub>A</sub>.
- Pulse test duration = 300 μs; duty cycle ≤ 3%.

NVA

# n-channel JFETs designed for . . .

## ■ Audio and Sub-Audio Amplifiers


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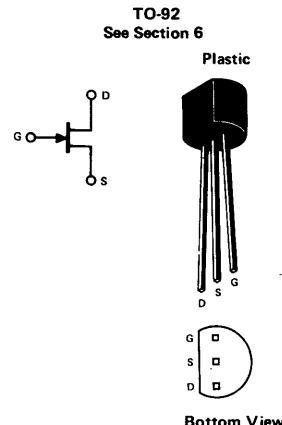
**Performance Curves NPA**  
**See Section 4**

### BENEFITS

- Ultra Low Noise

$\overline{e}_n = 8 \text{ nV}/\sqrt{\text{Hz}}$  Typical at 10 Hz

$\overline{e}_n = 2 \text{ nV}/\sqrt{\text{Hz}}$  Typical at 1 kHz



### ABSOLUTE MAXIMUM RATINGS (25°C)

Gate-Drain or Gate-Source Voltage (Note 1) . . . . .	-40V
Gate Current . . . . .	50 mA
Total Device Dissipation at 25°C Ambient (Derate 3.27 mW/°C) . . . . .	360 mW
Operating Temperature Range . . . . .	-55 to 135°C
Storage Temperature Range . . . . .	-55 to 150°C
Lead Temperature Range (1/16" from case for 10 seconds) . . . . .	300°C

### ELECTRICAL CHARACTERISTICS (25°C unless otherwise noted)

	Characteristic	J230			J231			J232			Unit	Test Conditions
		Min	Typ	Max	Min	Typ	Max	Min	Typ	Max		
1	I <sub>GSS</sub> Gate Reverse Current (Note 2)			-250			-250			-250	pA	V <sub>DS</sub> = 0, V <sub>GS</sub> = -30 V
2	S <sub>T</sub> V <sub>GS(off)</sub> Gate-Source Cutoff Voltage	-0.5		-3	-1.5		-5	-3		-6	V	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 1 μA
3		A <sub>T</sub> BV <sub>GSS</sub> Gate-Source Breakdown Voltage	-40		-40		-40					
4	I <sub>DS</sub> Saturation Drain Current (Note 3)	0.7		3	2		6	5		10	mA	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0
5	I <sub>G</sub> Gate Current (Note 2)		-10			-10			-10		pA	V <sub>DG</sub> = 10 V, I <sub>D</sub> = 0.5 mA
6	D g <sub>fs</sub> Common-Source Forward Transconductance (Note 3)	1,000		3,500	1,500		4,000	2,500		5,000	μmho	f = 1 kHz
7		Y <sub>N</sub> g <sub>os</sub> Common-Source Output Conductance		1.5			3			5		
8	A <sub>M</sub> C <sub>iss</sub> Common-Source Input Capacitance	12			12			12			pF	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0
9		I <sub>C</sub> C <sub>rss</sub> Common-Source Reverse Transfer Capacitance		2			2			2		
10	C <sub>rss</sub> Equivalent Short Circuit Input Noise Voltage		8	30		8	30	8	30	$\frac{nV}{\sqrt{\text{Hz}}}$	f = 10 Hz	
11			2			2		2				f = 1 kHz

#### NOTES:

1. Geometry is symmetrical. Unit may be operated with source and drain leads interchanged.
2. Approximately doubles for every 10°C increase in T<sub>A</sub>.
3. Pulse test duration = 2 ms.

NPA